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Silicon isotope measurement in zircon by laser ablation multiple collector inductively coupled plasma mass spectrometry

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ABSTRACT

This study reports the first Si isotope data measured in zircon using nanosecond laser ablation multiple collector inductively coupled plasma mass spectrometry. Long-term (>2 years) external reproducibility obtained on the 91500 zircon standard is 0.13‰ and 0.21‰ (2SD) for δ29Si and δ30Si (per mil deviation from the
quartz reference NBS 28), respectively, and typical precision on a single run is on the order of 0.10‰ and 0.12‰ (2SE) for δ²⁹Si and δ³⁰Si, respectively. Our results show good consistency between laser ablation multiple collector inductively coupled plasma mass spectrometry (LA-MC-ICP-MS) and solution multiple collector inductively coupled plasma mass spectrometry (S-MC-ICP-MS) / secondary ionization mass spectrometry (SIMS) data demonstrating that the Si isotopic composition of zircon can be accurately measured by LA-MC-ICP-MS. Obtained δ³⁰Si values on natural zircon standards range from -0.32 ± 0.23‰ (2SD) for 91500 to -0.47 ± 0.17‰ for MudTank, whereas the MUN (synthetic) zircon standards have lower δ³⁰Si values around -2.0‰ (e.g. -2.08 ± 0.17‰ for MUN-1-2b). Silicon isotope measurements by LA-MC-ICP-MS open new possibilities for studying zircon formation in various geological contexts.

1. Introduction

Silicon is the third most abundant element on Earth (e.g., McDonough, 2003) and it commonly bonds with oxygen to form SiO₄ tetrahedrons that represent the building blocks of all silicates. Silicon is therefore deeply involved in a lot of processes within and at the surface of the Earth. Silicon has three stable isotopes; ²⁸Si (92.23%), ²⁹Si (4.68%), and ³⁰Si (3.09%), and the measurement of their relative abundances has long been developed for various applications in planetary and Earth sciences, as well as in biological and environmental studies (e.g., Poitrasson, 2017; Ding et al., 2018; Sutton et al., 2018). Most studies have focused on bulk sample measurement (e.g., Clayton et al., 1978; Ziegler et al., 2005; André et al., 2006; Van den Boorn et al., 2010; Savage et al., 2011; Opfergelt et al., 2012; Zambardi et al., 2013; Deng et al., 2019) but analytical development and scientific needs have conducted to the analysis of Si
isotopes with *in-situ* techniques such as secondary ionization mass spectrometry (SIMS) and laser ablation multiple collector inductively coupled plasma mass spectrometry (LA-MC-ICP-MS) (e.g., Robert and Chaussidon, 2006; Shahar and Young, 2007; Chmeleff et al., 2008; Marin-Carbonne et al., 2010). SIMS measurements successfully helped decipher small scale heterogeneities and processes in SiO$_2$-rich materials and some silicates such as quartz and olivine (e.g., Marin-Carbonne, 2014; Kleine et al., 2018; Villeneuve et al., 2019). This *in-situ* approach is required to study crystals with complex histories such as zircon (ZrSiO$_4$) which has recently been investigated by Trail et al. (2018) using SIMS. The major limitation of these SIMS measurements is the analytical precision which is on average ~0.4‰ (2SE) and, hence, prevents good resolution between a large amount of data given that high-temperature processes induce limited Si isotope fractionation (e.g., Savage et al., 2014). A few studies utilized LA-MC-ICP-MS to measure Si isotope signatures in rocks and minerals (e.g., Shahar and Young, 2007; Chmeleff et al., 2008; Ziegler et al., 2010; Janney et al., 2011; Schuessler and Blackenburg, 2014; Chen et al., 2016; Frick et al., 2016) and consistently showed that analytical precisions can be better than 0.2‰ (2SE). Therefore, LA-MC-ICP-MS could be an alternative and very likely useful technique for *in-situ* studies of Si isotopes in zircon. These studies also underpinned that the type of laser used (i.e., nanosecond or femtosecond) plays a very important role as SiO$_2$-rich matrices (e.g., quartz, chert) do not always couple well with nanosecond laser beams, thereby inducing poor external reproducibility (e.g., Poitrasson and D’abzac, 2017). However, other types of silicate matrices, such as glass, olivine, and zircon, commonly behave very well which such lasers. Given that the vast majority of LA-MC-ICP-MS facilities are equipped with nanosecond lasers (excimer or solid-state), it seemed more...
useful for the scientific community to develop Si isotope measurements using nanosecond LA-MC-ICP-MS.

Zircon is a mineral extensively used in Earth Sciences because it can provide precise geochronological information using U-Th-Pb isotope systems (e.g., Tilton et al., 1957; Schoene, 2014), as well as source characteristics using Hf and O isotopes (Patchett, 1983; Valley, 2003). In addition, it is ubiquitous in granite (sensus largo), very resistant to weathering and erosion, and most elements diffuse very slowly within its lattice (Lee et al., 1997; Cherniak and Watson, 2003, 2007). Given that granite is the main constituent of continents, zircon in magmatic rocks and detrital sediments has long been used to study the growth of continents, which remains one of the major unresolved issues in Earth Sciences (e.g., Fedo et al., 2003; Iizuka et al., 2005; Guittreau et al., 2012; Roberts and Spencer, 2015). Silicon stable isotopes have been used to discriminate some granite types from others (Savage et al., 2012; André et al., 2019; Deng et al., 2019) and their application to zircon is promising to study the growth of continents, granite petrogenesis, and lithosphere-hydrosphere interactions in deep-time geology (Trail et al., 2018). Theoretical work predicted that Si isotope fractionation should occur between minerals and their parental melt as a function of temperature, melt polymerization, mineral chemistry and Si-O bond lengths (e.g. Méheut et al., 2009; Méheut and Schauble, 2014; Qin et al., 2016). According to Qin et al. (2016), enrichment in $^{30}$Si linked to fractionation follows the sequence quartz > albite > anorthite > olivine ~ zircon > enstatite > diopside. Consequently, zircon is expected to be enriched in light isotopes compared to its parental melt. This was recently confirmed by measurements on natural zircons (Trail et al., 2018) as well as by experimental work (Trail et al., 2019). The present contribution explores the capability of nanosecond LA-
2. Material and Methods

2.1. Standard material

Reference materials in the form of glass and crystallized matrices (i.e., olivine and zircon) were used for the optimization of the analytical conditions and the determination of an appropriate protocol for silicon isotope measurements by LA-MC-ICP-MS. Glass reference materials used in this study were SRM NIST 612, USGS BHVO-2 and GSC-1G (e.g., Jochum et al., 2005, 2011). The San Carlos olivine reference material (e.g., Jarosewich et al., 1980) was also investigated together with zircon standards 91500 (syenite-derived; Wiedenbeck et al., 1995), MudTank (carbonatite-derived; Black and Gulson, 1978), KIM (kimberlite-derived; Valley, 2003; Trail et al., 2018), AS3 (gabbro-derived; Paces and Miller, 1993), R33 (monzodiorite-derived; Black et al., 2004), QGNG (Quartz-gabbronorite-derived; Black et al., 2003), Peixe (Alkaline-rich granitoid-derived; Chang et al., 2006), Plešovice (hyperpotassic granulite-derived; Sláma et al., 2008), and the artificial standards MUN from the Memorial University of NewFoundland (Fisher et al., 2011).

2.2. Measurements

2.2.1. Solution MC-ICP-MS characterization of zircon standards

In order to determine the Si isotope composition of zircons and to check the validity of results obtained using LA-MC-ICP-MS, we have analyzed several well-known zircon reference materials using solution mode technique (S-MC-ICP-MS) modified from that described in Deng et al. (2019). Crushed powders of 91500 and Plešovice zircons (1.5-
6.8 mg), as well as MUN-1 (0.6 mg), were dissolved using a NaOH fusion method revised after Georg et al. (2006). The samples were fused in Ag crucibles with proper additions of NaOH pellet (120 mg for 91500 and Plešovice zircons and only 40 mg for MUN-1) at 720 °C for 15 min in a furnace. Afterwards, the glassy samples were dissolved in Milli-Q H₂O by heating and ultrasonicating. The samples were, then, transferred into pre-cleaned tubes by Milli-Q H₂O rinsing, achieving total volumes of the solutions for 91500 and Plešovice zircons to 30-40 ml and 10 ml for MUN-1 zircon. This step control in dissolution volume maintains Si concentrations in the sample solutions to be sufficiently high (at µg/g or sub µg/g level) for subsequent isotopic measurements. For the digestions on ≥ 1 mg samples, purified 16 M HNO₃ (0.1-0.3 mL) were properly added to acidify the solutions until they became clear.

Sample aliquots containing 20 µg of Si were passed through columns hosting 1.8 mL BioRad AG50X-12 (200-400 meshes) cation exchange resin (Pringle et al., 2014). At neutral conditions, the dissolved Si would be eluted by 5 mL Milli-Q H₂O rinsing, whereas the cations would be retained on the columns by the resin. Note that the resin was discarded after every single use to avoid any memory effect of any neo-formed insoluble Zr particles under weak-acids. After purification, the solutions were further diluted and acidified into 10 mL (2 µg/g) Si solutions in 0.2 M HNO₃. The sample solutions were measured for the Si isotopic compositions on the Thermo Scientific Neptune Plus multi-collector inductively coupled plasma mass spectrometer (MC-ICP-MS) at the Institut de Physique du Globe de Paris (IPGP). The solutions were introduced via a quartz-made spray chamber. The typical sensitivity was 10-12 V on 28Si⁺ for 2 µg/g of Si with an uptake rate of 100 µL/min under a medium resolution mode (M/ΔM ~5000). In order to avoid isobaric interferences from 14N16O⁺ on 30Si⁺, the measurements of ion intensities were conducted at the lower masses of peaks 28,
Reference materials NBS 28 and BHVO-2 were processed following the same protocols as for zircon standards, and the purified NBS 28 was used as the bracketing standard. A standard-sample bracketing method was used, meaning that NBS 28 solutions were measured before and after each analysis of BHVO-2 and zircon reference material. Each sample was analyzed 3-6 times, and each measurement consisted of 25 cycles with 8.389 s of integration time per cycle. After every analysis, a wash-out with 0.5 M HNO₃ and 0.2 M HNO₃ in steps was carried out. The Si blank from the whole procedure was ≤ 15 ng, which is much lower than the Si masses of the samples (40-2000 µg). After Si purification, each solution was checked using Q-ICP-MS and no Zr was detected whereas other elements, when detected, were all below 1 ppb. Note that we managed to strictly match the NO₃⁻ contents and Si concentrations of the bracketing NBS 28 solutions to the corresponding sample solutions, which minimizes possible matrix effects.

### 2.2.2. Silicon isotope measurements by LA-MC-ICP-MS

Laser ablation multiple collector inductively coupled plasma mass spectrometry measurements were conducted at Laboratoire Magmas et Volcans (LMV, Clermont-Ferrand, France) using a Resonetics Resolution M-50 coupled to a Thermo Scientific Neptune Plus. Analytical conditions are provided in Table 1. The abundance of silicon isotopes was measured in high resolution mode (M/ΔM=7800) and on the low-mass shoulder of 28, 29, and 30 peaks to avoid isobaric interferences (e.g., Shahar and Young, 2007; Chmeleff et al., 2008; Janney et al., 2011; Schuessler and Von Blackenburg, 2014; Frick et al., 2016). Silicon isotope analyses were performed in standard-bracketing (i.e., single measurement of an unknown bracketed by two
analyses of a matrix-matched standard, or batch of two unknowns bracketed by two measurements of a matrix-matched standard. During the development of the technique, we analyzed quartz, notably NBS 28, and silica-rich matrices (e.g., chert, opale), but observed either very noisy signals or even breakage of crystals during ablation. As a consequence, we could not analyze the international quartz reference standard NBS 28 (NIST RM 8546) to normalize our data to. Instead, we used NIST 612 or the zircon standard 91500 as our normalizing reference and recalculated all data relative to NBS 28. Results are reported in delta notation, $\delta^{29}$Si and $\delta^{30}$Si, which express per mil deviations from a reference, and are calculated using the following equations.

$$\delta^x \text{Si (‰)} = \left( \frac{x_{\text{Si sample}}}{x_{\text{Si reference}}} - 1 \right) \times 1000 \quad (1)$$

with $x$ being either 29 or 30. Several ways of reporting analytical uncertainties have been adopted in the literature (e.g., 1 SD, 1 SE, 2 SD, 2 SE, 95% confidence). For the sake of consistency, we report internal precision (i.e., within-run error or analytical precision) as 2 standard-errors (2SE), also called reduced-error, which is 2 times the standard-deviation divided by the square-root of the number of measurements. This is the case for single zircon measurement. Note that the internal precision reported for $\delta^{29}$Si and $\delta^{30}$Si of single measurements include a quadratic addition of the errors on the bracketing standards. The external reproducibility (e.g., mean of measurements on the same zircon standard) is, however, reported as 2 standard-deviations (2SD). When we quote literature data and their associated uncertainties, we report them in the same way as our data and, hence, recalculated them if they were reported differently in the original publications. We processed Si isotope data both with and without applying background correction and observed no difference in the obtained $\delta^{29}$Si and $\delta^{30}$Si. However, data that were corrected for background exhibited poorer external reproducibility likely due
to the limited signal-over-noise ratio (Fig. 1). As a consequence, all data presented in this contribution were not corrected for background. We also applied a 2SD filter to remove outliers.

A critical issue with high-temperature Si isotope geochemistry is the limited fractionation which, in turn, results in small isotopic variability (e.g., Savage et al. 2014, Deng et al., 2019). This requires an appropriate analytical precision so as to be able to discriminate distinct isotopic compositions. Consequently, we compared Si isotopes measurements obtained by spot and line modes on synthetic glass, olivine, and zircon standards. We adjusted spot size and frequency together in order to obtain highest and most stable signals, and set the fluence to ~3 J/cm² regardless of spot size and frequency used because it corresponds to ablation conditions that are optimal for other isotope systems (i.e., U-Pb and Lu-Hf; Guitreau et al., 2019).

3. Results

3.1. S-MC-ICP-MS results

Results for basalt (BHVO-2) standards are in good agreement with literature values as we obtained $\delta^{29}\text{Si}$ and $\delta^{30}\text{Si}$ of $-0.14 \pm 0.09$ and $-0.28 \pm 0.15\%$ (n = 60; 2SD), respectively which compares well with a $\delta^{30}\text{Si} = -0.29 \pm 0.05\%$; from Schuessler and Von Blackenburg (2014) (Table 2).

The two different fragments of 91500 analyzed by S-MC-ICP-MS, labeled 91500-MG and 91500-Corfu, exhibit very consistent $\delta^{30}\text{Si}$ values between $-0.39 \pm 0.10$ and $-0.36 \pm 0.02\%$ (2SD; Table 2). This is also true for $\delta^{29}\text{Si}$ with values of $-0.19 \pm 0.09$ and $-0.20 \pm 0.02\%$ (2SD; Table 2). The 4 different fragments of Plešovice zircon standard similarly gave consistent $\delta^{30}\text{Si}$ values between $-0.39 \pm 0.10$ and $-0.34 \pm 0.24\%$ (2SD; Table 2). The artificial zircon standard MUN-1, which corresponds to MUN-1-2b from
MUNzirc second series (Hanchar personal communication), gave a mean $\delta^{30}\text{Si}$ value of $-2.08 \pm 0.17\%\text{oo}$ (2SD; Table 2), which is very light compared to natural zircons. The standards 91500 and Plešovice exhibit similar Si isotope values with those obtained by S-MC-ICP-MS and SIMS in Trail et al. (2018).

### 3.2. LA-MC-ICP-MS results

The results are given in Tables 3-5 and S1-S5, and illustrated in Figures 1-5. Figure 1 shows typical LA-MC-ICP-MS measurements of 91500 in spot and line modes and it is visible that Si isotopic ratios are stable throughout a run for both modes. The spot measurement (Fig. 1A) is affected by intensity decrease over the course of the analysis which is due to deepening of the laser pit. On the contrary, line mode produces more stable intensities that also translate into more reproducible signals and isotopic ratios. Note that Si backgrounds are high which is common with laser ablation measurements. Table 3 and Figure 2 further show that line mode provides better internal precision and external reproducibility than spot mode regardless of the type of matrix analyzed and laser setting used. Such observation is consistent with those reported by Schuessler and von Blanckenburg (2014). In order to test LA-MC-ICP-MS measurement accuracy, we analyzed San Carlos olivine and 91500 zircon and used NIST 612 as a normalizing reference. It can be seen in Table 4 that obtained $\delta^{29}\text{Si}$ and $\delta^{30}\text{Si}$ for San Carlos and 91500 are inconsistent with expected values. Schuessler and Von Blackenburg (2014) showed that differences in Si intensity between a sample and its bracketing standard could result in inaccurate $\delta^{29}\text{Si}$ and $\delta^{30}\text{Si}$. The synthetic glass, NIST 612, has a much higher Si concentration than olivine and zircon and, hence, we have adjusted the Si intensity between San Carlos olivine and NIST 612 by changing the frequency of the laser and by doing measurements in line mode. However, obtained values for San
Carlos olivine are still inaccurate (Table 4) which highlights the matrix-sensitive nature of isotope measurements by LA-MC-ICP-MS using nanosecond lasers. Therefore, all zircon analyses presented in what follows correspond to line mode (Fig. 1B) that were conducted with a frequency of 6 Hz, a spot size of 33 µm, a fluence of 3 J/cm², a traverse rate of 1.6 µm/s, and normalized to 91500. The spot size and frequency were selected to obtain the highest and most stable signal according to the MC-ICP-MS sensitivity without compromising spatial resolution too much. Data for 91500 gathered over a period of more than 2 years show an external reproducibility of 0.21‰ on the self-bracketed δ³⁰Si (2SD; Fig. 3), while internal precisions vary between 0.09 and 0.16‰ (2SE; Table S3).

Figure 4a illustrates that LA-MC-ICP-MS data align along a least-squares regression line of 0.5132 ± 0.0034 (R² = 0.98) which falls right in between theoretical predictions for mass-dependent fractionation (i.e., equilibrium = 0.5178 and kinetic = 0.5092; e.g. Zambardi and Poitrasson, 2011; Savage et al., 2014). Moreover, both S-MC-ICP-MS and LA-MC-ICP-MS measurements have consistent fractionation behavior along the terrestrial mass-dependent fractionation lines (Figure 4b). Finally, Figure 5 demonstrates that our new LA-MC-ICP-MS data comply well with Si isotope data obtained with other techniques on the same zircon standards (i.e., S-MC-ICP-MS in this study and S-MC-ICP-MS/SIMS techniques in Trail et al., 2018).

Silicon isotope data for natural zircon standards overall show very little variability with δ³⁰Si ranging from -0.32 ± 0.23‰ for 91500 to -0.47 ± 0.17‰ for MudTank (2SD; Table 5). These values are consistent with Si isotope data on zircon published elsewhere (Trail et al., 2018, 2019, Figure 5 and Table 5). 91500 zircon analyzed in this study by LA-MC-ICP-MS and by S-MC-ICP-MS gave consistent δ³⁰Si of -0.32 ± 0.23‰ and -0.39 ± 0.10‰, respectively. AS3 zircon analyzed in this study
by LA-MC-ICP-MS gave a δ³⁰Si of -0.44 ± 0.23‰ which is consistent within uncertainty with the value of -0.36 ± 0.35‰ (2SD; Table 5) obtained by SIMS in Trail et al. (2018). KIM zircon gave a LA-MC-ICP-MS δ³⁰Si of -0.40 ± 0.23‰ identical to the S-MC-ICP-MS value of -0.41 ± 0.01‰ from Trail et al. (2018). Kuehl Lake zircon gave a LA-MC-ICP-MS δ³⁰Si of -0.38 ± 0.12‰ which is also consistent within uncertainty with the S-MC-ICP-MS value of -0.29 ± 0.04‰ published in Trail et al. (2018). MudTank zircon displays a LA-MC-ICP-MS δ³⁰Si of -0.47 ± 0.17‰ which is consistent, within error, with the S-MC-ICP-MS value of -0.34 ± 0.03‰ from Trail et al. (2018). Plešovice zircon gave a LA-MC-ICP-MS δ³⁰Si of -0.38 ± 0.18‰ identical to S-MC-ICP-MS analyses from this study (δ³⁰Si = -0.39 ± 0.06‰). The artificial MUN zircon standards exhibit consistently lighter Si isotope compositions compared to those shown by natural standards. MUN zircons have slightly variable δ³⁰Si that range from -1.67 ± 0.14‰ for MUN-0 to -2.05 ± 0.30‰ (2SD; Table 5) for MUN-4. The value of -2.00 ± 0.22‰ obtained for MUN-1 using LA-MC-ICP-MS (Table 5) is identical within uncertainty to that obtained by S-MC-ICP-MS (i.e., -2.08 ± 0.17‰; Table 2), hence, confirming the enrichment of this synthetic zircon in light Si isotopes.

4. Discussion

Comparisons between Si isotope signatures of natural and synthetic zircons analyzed by LA-MC-ICP-MS and S-MC-ICP-MS in this study, as well as data from the literature (S-MC-ICP-MS and SIMS, Trail et al., 2018), exhibit general good consistency that indicates that zircon data by LA-MC-ICP-MS are accurate and robust. Moreover, although less precise than S-MC-ICP-MS analyses (δ³⁰Si within-run 2 standard error of ~0.02-0.05‰), LA-MC-ICP-MS data (δ³⁰Si within-run 2 standard error of ~0.10-0.15‰) are more precise than currently available SIMS data (δ³⁰Si within-run 2
standard error of ~0.30-0.40‰) and, hence, represent a relevant compromise between
precision and spatial resolution. Therefore, Si isotope measurements in zircon by LA-
MC-ICP-MS open new possibilities for zircon studies in various geological contexts
(e.g., magmatic differentiation, crustal growth).

This technique could be improved further in the future by reducing the high Si
background which is visible in Figure 1 and likely influences external reproducibility
of Si isotope signatures. Moreover, as shown in Zambardi and Poitrasson (2011) silicon
isotopic fractionation induced by MC-ICP-MS instruments evolve non-linearly over
time, which requires a strict standard-bracketing procedure to be applied when
measuring Si isotopes by LA-MC-ICP-MS. However, if ways to stabilize the time-
induced drift in Si isotope ratios in MC-ICP-MS are found they would certainly help
improve external reproducibility of $\delta^{29}$Si and $\delta^{30}$Si.

One pitfall of LA-MC-ICP-MS analysis, compared to SIMS, is the quantity of
material required to achieve reasonable precision. In this contribution, we have decided
to conduct analyses in line mode so as to obtain the best internal precision and external
reproducibility. In the context of zircon studies, processing by lines over spots has the
advantage of better coupling internal textures observed in cathodoluminescence (CL)
and back-scattered electron (BSE) images to the obtained isotopic information.
However, such lines require a rather large part of zircons to be swept across (~100 µm
long traverse). Possible chemical/isotopic heterogeneities may be invisible at the
sampling scale. One may compromise the precision for spatial resolution by doing spots
but would likely reduce the precision and hence the resolvability. This issue can be
dealt with on a case-to-case basis depending on the size and complexity of zircons
studied.
5. Conclusions

In this contribution, we have set up a protocol for Si isotope measurements in zircon by nanosecond LA-MC-ICP-MS. Analyses performed in line mode were preferred to those obtained by spot mode because of their better internal precision and external reproducibility. Within-run error on zircon δ^{30}Si are on the order of ~0.10-0.15‰ (2SE) and external precision of ~0.15-0.30‰ (2SD). Our LA-MC-ICP-MS data are in line with those acquired with S-MC-ICP-MS and SIMS, therefore highlighting the accuracy of silicon isotope measurements in zircon by LA-MC-ICP-MS. This technique, therefore, offers an additional way to existing methods aiming to study zircon formation in different geological contexts.

Conflicts of interest

The authors have no conflicts to declare.

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References


**Figure and Table captions**

Table 1. LA-MC-ICP-MS operating conditions

Table 2. Silicon isotope results for zircons analyzed by S-MC-ICP-MS

Table 3. External reproducibility of self-normalized standards

Table 4. Summary of Si isotope measurements by LA-MC-ICP-MS of San Carlos and 91500 normalized to NIST 612

Table 5. Silicon isotope results for zircons analyzed by LA-MC-ICP-MS

Figure 1. Signal and isotope ratio evolutions throughout a typical analysis of the zircon standard 91500 in spot (A) and line (B) modes using the same analytical conditions (i.e., spot size of 33 µm, frequency of 6 Hz, fluence of 3 J/cm² and sweeping rate of 1.6 µm/s for the line mode, and). In the insets, δ²⁹Si and δ³⁰Si values were calculated by normalization to the average ²⁸Si/²⁸Si and ³⁰Si/²⁸Si of the corresponding analysis. Note that during ablation both the isotope ratios are stable, despite high intensities of Si in the background (laser off).
Figure 2. External reproducibility of Si isotopes in different matrices. Delta values are self-normalized for each standard. Note the general better external reproducibility of line analyses compared to spots regardless of the matrix analyzed.

Figure 3. Long-term (>2 years) reproducibility of Si isotope signatures in 91500 (self-bracketed).

Figure 4. Silicon isotope results for zircon analysed by LA-MC-ICP-MS and S-MC-ICP-MS. Figure A shows the relationship between $\delta^{29}\text{Si}$ and $\delta^{30}\text{Si}$ for all single LA-MC-ICP-MS measurements whereas B exhibits the relationship between $\delta^{29}\text{Si}$ and $\delta^{30}\text{Si}$ for averages of all zircon standards analyzed by LA-MC-ICP-MS and S-MC-ICP-MS. Note that MUN artificial zircon standards have very light Si isotope signatures compared to natural zircons and that data align along the terrestrial mass-dependent fractionation lines, labeled EMFL and KMFL for equilibrium and kinetic fractionation, respectively.

Figure 5. Comparison between LA-MC-ICP-MS and S-MC-ICP-MS/SIMS data for zircon standards (MUN-1, 91500, AS3, KIM, Kuehl Lake, MudTank, and Plešovice) from this study and Trail et al. (2018). All data align along a line with a slope of 1, therefore, indicating very good agreement between techniques.

**Supplementary Table captions**

Table S1. All LA-MC-ICP-MS results for standards

Table S2. Results for Si isotope measurements by LA-MC-ICP-MS of San Carlos olivine and 91500 zircon normalized to NIST 612
Table S3. All results for 91500 (self-bracketed) analyzed by LA-MC-ICP-MS in line mode.

Table S4. All Si isotope data for zircon analyzed by LA-MC-ICP-MS in line mode.

Table S5. All raw LA-MC-ICP-MS data.
A) Spot

B) Line

Si intensity (V)

Laser on

$^{28}\text{Si}$

$^{29}\text{Si}$

$^{30}\text{Si}$

Time (s)

$\delta^{29}\text{Si}$ (‰)

Average = 0.00 ± 0.13 ‰ (2SE)

$\delta^{30}\text{Si}$ (‰)

Average = 0.00 ± 0.06 ‰ (2SE)

$\delta^{30}\text{Si}/^{28}\text{Si}$ (‰)

Average = 0.00 ± 0.13 ‰ (2SE)

$\delta^{30}\text{Si}/^{28}\text{Si}$ (‰)

Average = 0.00 ± 0.06 ‰ (2SE)

Time (s)
Average $\delta^{29}\text{Si} = -0.01 \pm 0.13$‰ (2SD; $n = 221$)

Average $\delta^{30}\text{Si} = -0.01 \pm 0.21$‰ (2SD; $n = 221$)
A

MUN artificial zircons

Natural zircons

\[ \alpha = 0.5132 \pm 0.0034 \quad (R^2 = 0.98) \]

All LA-MC-ICP-MS measurements

B

KMFL = 0.5092

Solution data

LA-MC-ICP-MS data

MUN artificial zircons

Natural zircons

EMFL = 0.5178

Averages for zircon standards
$\delta^{30}\text{Si}$ by LA-MC-ICP-MS (‰)

$\delta^{30}\text{Si}$ by S-MC-ICP-MS/SIMS (‰)

MUN artificial zircons

Natural zircons

1:1
Table 1. LA-MC-ICP-MS operating conditions

<table>
<thead>
<tr>
<th>Analysis</th>
<th>Si isotopes</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Laboratory</strong></td>
<td>Magmas et Volcans</td>
</tr>
<tr>
<td>Cup configuration</td>
<td>L3, C, H3</td>
</tr>
<tr>
<td>Mass measured</td>
<td>28, 29, 30</td>
</tr>
<tr>
<td>MC-ICP-MS model</td>
<td>Thermo Neptune Plus</td>
</tr>
<tr>
<td>Interface type</td>
<td>Jet (high sensitivity)</td>
</tr>
<tr>
<td>Cones</td>
<td>X-Cones</td>
</tr>
<tr>
<td>Resistors</td>
<td>$10^{11}$ Ohms</td>
</tr>
<tr>
<td>Resolution</td>
<td>High (M/ΔM~7800)</td>
</tr>
<tr>
<td>Forward Power</td>
<td>1200 W</td>
</tr>
<tr>
<td>Auxiliary gas (Ar)</td>
<td>0.7-0.8 L/min</td>
</tr>
<tr>
<td>Ar sample</td>
<td>0.9-1.1 L/min</td>
</tr>
<tr>
<td>SQUID</td>
<td>On</td>
</tr>
<tr>
<td><strong>Data acquisition</strong></td>
<td>Time resolved analysis</td>
</tr>
<tr>
<td>Scanning mode</td>
<td>Static multi-collection</td>
</tr>
<tr>
<td>Integration time per isotope</td>
<td>1s</td>
</tr>
<tr>
<td>Background counting time</td>
<td>20-30 s</td>
</tr>
<tr>
<td>Sample measurement time</td>
<td>40-60s</td>
</tr>
<tr>
<td>Measurement type</td>
<td>Standard bracketing</td>
</tr>
<tr>
<td>External standard</td>
<td>NIST 612, 91500</td>
</tr>
<tr>
<td><strong>Laser model</strong></td>
<td>Resonetics Resolution M-50E</td>
</tr>
<tr>
<td>Wavelength</td>
<td>193 nm</td>
</tr>
<tr>
<td>Pulse duration</td>
<td>5 ns</td>
</tr>
<tr>
<td>Energy</td>
<td>2-5 mJ</td>
</tr>
<tr>
<td>Fluence</td>
<td>~3 J/cm²</td>
</tr>
<tr>
<td>Frequency</td>
<td>6-10 Hz</td>
</tr>
<tr>
<td>Spot size</td>
<td>27-40 μm</td>
</tr>
<tr>
<td>Carrier gas</td>
<td>He</td>
</tr>
<tr>
<td>Carrier gas flow</td>
<td>0.65-0.75 L/min</td>
</tr>
<tr>
<td>Traverse rate</td>
<td>1.6 μm/s</td>
</tr>
</tbody>
</table>
Table 2. Si isotope results for zircons analyzed by S-MC-ICP-MS

<table>
<thead>
<tr>
<th>Sample</th>
<th>$\delta^{29}$Si* (‰)</th>
<th>2SD</th>
<th>$\delta^{30}$Si* (‰)</th>
<th>2SD</th>
<th>n</th>
</tr>
</thead>
<tbody>
<tr>
<td>NBS 28 (NIST 8546)</td>
<td>0.00</td>
<td>0.08</td>
<td>0.00</td>
<td>0.13</td>
<td>236</td>
</tr>
<tr>
<td>BHVO-2</td>
<td>-0.14</td>
<td>0.09</td>
<td>-0.28</td>
<td>0.15</td>
<td>60</td>
</tr>
<tr>
<td>91500-MG</td>
<td>-0.19</td>
<td>0.09</td>
<td>-0.39</td>
<td>0.10</td>
<td>4</td>
</tr>
<tr>
<td>91500-Corfu</td>
<td>-0.20</td>
<td>0.02</td>
<td>-0.36</td>
<td>0.02</td>
<td>4</td>
</tr>
<tr>
<td>Plešovice-MG</td>
<td>-0.20</td>
<td>0.06</td>
<td>-0.39</td>
<td>0.06</td>
<td>4</td>
</tr>
<tr>
<td>Plešovice-IPGP</td>
<td>-0.18</td>
<td>0.10</td>
<td>-0.34</td>
<td>0.24</td>
<td>4</td>
</tr>
<tr>
<td>Plešovice-IPGP</td>
<td>-0.18</td>
<td>0.03</td>
<td>-0.37</td>
<td>0.07</td>
<td>4</td>
</tr>
<tr>
<td>Plešovice-IPGP</td>
<td>-0.17</td>
<td>0.09</td>
<td>-0.37</td>
<td>0.08</td>
<td>4</td>
</tr>
<tr>
<td>MUN-1</td>
<td>-1.04</td>
<td>0.04</td>
<td>-2.08</td>
<td>0.17</td>
<td>4</td>
</tr>
</tbody>
</table>

* normalized to NBS 28
<table>
<thead>
<tr>
<th>Name</th>
<th>δ²⁹Si 2SD</th>
<th>δ³⁰Si 2SD</th>
<th>Analysis</th>
<th>Repetition rate</th>
<th>Spot size</th>
<th>Fluence</th>
<th>n</th>
</tr>
</thead>
<tbody>
<tr>
<td>NIST 612</td>
<td>-0.01</td>
<td>0.35</td>
<td>-0.02</td>
<td>0.83 Spot</td>
<td>10 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>NIST 612</td>
<td>0.00</td>
<td>0.11</td>
<td>0.01</td>
<td>0.22 Line</td>
<td>6 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>NIST 612</td>
<td>0.01</td>
<td>0.14</td>
<td>0.13</td>
<td>0.52 Spot</td>
<td>6 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>NIST 612</td>
<td>0.04</td>
<td>0.11</td>
<td>0.11</td>
<td>0.20 Line</td>
<td>6 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>BHVO-2</td>
<td>-0.08</td>
<td>0.43</td>
<td>-0.19</td>
<td>0.57 Spot</td>
<td>6 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>BHVO-2</td>
<td>0.03</td>
<td>0.18</td>
<td>0.06</td>
<td>0.35 Line</td>
<td>6 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>BHVO-2</td>
<td>0.02</td>
<td>0.15</td>
<td>0.04</td>
<td>0.22 Line</td>
<td>10 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>GSC-1G</td>
<td>-0.08</td>
<td>0.19</td>
<td>-0.09</td>
<td>0.67 Spot</td>
<td>6 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>GSC-1G</td>
<td>0.00</td>
<td>0.20</td>
<td>0.07</td>
<td>0.35 Line</td>
<td>6 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>San Carlos</td>
<td>-0.01</td>
<td>0.13</td>
<td>-0.01</td>
<td>0.24 Spot</td>
<td>6 Hz</td>
<td>40 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>San Carlos</td>
<td>0.00</td>
<td>0.10</td>
<td>0.00</td>
<td>0.09 Line</td>
<td>6 Hz</td>
<td>40 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>San Carlos</td>
<td>-0.01</td>
<td>0.14</td>
<td>-0.02</td>
<td>0.29 Spot</td>
<td>10 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>San Carlos</td>
<td>0.00</td>
<td>0.13</td>
<td>0.01</td>
<td>0.22 Spot</td>
<td>10 Hz</td>
<td>40 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>91500</td>
<td>0.00</td>
<td>0.17</td>
<td>0.00</td>
<td>0.34 Spot</td>
<td>10 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>91500</td>
<td>0.00</td>
<td>0.06</td>
<td>0.00</td>
<td>0.15 Line</td>
<td>10 Hz</td>
<td>27 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>91500</td>
<td>-0.01</td>
<td>0.12</td>
<td>-0.02</td>
<td>0.26 Spot</td>
<td>6 Hz</td>
<td>40 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>91500</td>
<td>-0.01</td>
<td>0.08</td>
<td>-0.01</td>
<td>0.16 Line</td>
<td>6 Hz</td>
<td>40 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
<tr>
<td>91500</td>
<td>-0.01</td>
<td>0.13</td>
<td>-0.01</td>
<td>0.21 Line</td>
<td>6 Hz</td>
<td>33 μm</td>
<td>~3 J.cm⁻²</td>
</tr>
</tbody>
</table>
Table 4 - Summary of Si isotope measurements by LA-MC-ICP-MS of San Carlos and 91500 normalized to NIST 612

<table>
<thead>
<tr>
<th>Average</th>
<th>$\Delta^{29}\text{Si}(% \text{a})$</th>
<th>2 SD</th>
<th>$\Delta^{30}\text{Si}(% \text{a})$</th>
<th>2 SD</th>
<th>Laser setup</th>
<th>Mode</th>
<th>$\text{Si}<em>0/\text{Si}</em>{\text{NIST}}$</th>
<th>Literature</th>
</tr>
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<tbody>
<tr>
<td>San Carlos</td>
<td>-0.74</td>
<td>0.20</td>
<td>-1.44</td>
<td>0.51</td>
<td>6 Hz 40 $\mu$m</td>
<td>Spot</td>
<td>0.5</td>
<td>-0.20</td>
</tr>
<tr>
<td>San Carlos</td>
<td>-0.85</td>
<td>0.11</td>
<td>-1.67</td>
<td>0.43</td>
<td>10 Hz 27 $\mu$m</td>
<td>Spot</td>
<td>0.6</td>
<td>-0.20</td>
</tr>
<tr>
<td>San Carlos</td>
<td>-0.60</td>
<td>0.08</td>
<td>-1.19</td>
<td>0.22</td>
<td>10 Hz 27 $\mu$m</td>
<td>Raster</td>
<td>0.9</td>
<td>-0.20</td>
</tr>
<tr>
<td>91500</td>
<td>0.19</td>
<td>0.17</td>
<td>0.37</td>
<td>0.21</td>
<td>6 Hz 40 $\mu$m</td>
<td>Spot</td>
<td>0.6</td>
<td>-0.20</td>
</tr>
<tr>
<td>91500</td>
<td>0.00</td>
<td>0.31</td>
<td>-0.12</td>
<td>0.48</td>
<td>10 Hz 27 $\mu$m</td>
<td>Spot</td>
<td>0.7</td>
<td>-0.20</td>
</tr>
</tbody>
</table>

* Delta values are relative to NBS 28 but normalized to NIST 612 that was analyzed in the same conditions except for the rasters for which NIST 612 was analyzed using 6 Hz and 27 $\mu$m.

** S refers to sample (San Carlos or 91500) and NIST to NIST 612.

*** Delta values are relative to NBS 28.
Table 5. Si isotope results for zircons analyzed by LA-MC-ICP-MS

<table>
<thead>
<tr>
<th>Technique</th>
<th>Sample</th>
<th>δ(^{29})Si(^*) (%)</th>
<th>2SD</th>
<th>δ(^{30})Si(^*) (%)</th>
<th>2SD</th>
<th>n</th>
<th>Technique</th>
<th>δ(^{30})Si(^*) (%)</th>
<th>2SD</th>
<th>Reference</th>
</tr>
</thead>
<tbody>
<tr>
<td>LA-MC-ICP-MS</td>
<td>91500-MG</td>
<td>-0.15</td>
<td>0.10</td>
<td>-0.32</td>
<td>0.23</td>
<td>5</td>
<td>S-MC-ICP-MS</td>
<td>-0.39</td>
<td>0.10</td>
<td>This study</td>
</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>AS3</td>
<td>-0.25</td>
<td>0.13</td>
<td>-0.44</td>
<td>0.23</td>
<td>28</td>
<td>SIMS</td>
<td>-0.36</td>
<td>0.35</td>
<td>Trail et al. (2018)</td>
</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>KIM</td>
<td>-0.20</td>
<td>0.17</td>
<td>-0.40</td>
<td>0.23</td>
<td>16</td>
<td>S-MC-ICP-MS</td>
<td>-0.41</td>
<td>0.01</td>
<td>Trail et al. (2018)</td>
</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>Kuehl Lake</td>
<td>-0.25</td>
<td>0.11</td>
<td>-0.38</td>
<td>0.12</td>
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<td>S-MC-ICP-MS</td>
<td>-0.29</td>
<td>0.04</td>
<td>Trail et al. (2018)</td>
</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>MudTank</td>
<td>-0.23</td>
<td>0.12</td>
<td>-0.47</td>
<td>0.17</td>
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<td>S-MC-ICP-MS</td>
<td>-0.34</td>
<td>0.03</td>
<td>Trail et al. (2018)</td>
</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>MUN-0</td>
<td>-0.88</td>
<td>0.13</td>
<td>-1.67</td>
<td>0.14</td>
<td>14</td>
<td>-</td>
<td>-</td>
<td>-</td>
<td>-</td>
</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>MUN-1</td>
<td>-1.02</td>
<td>0.19</td>
<td>-2.00</td>
<td>0.22</td>
<td>8</td>
<td>S-MC-ICP-MS</td>
<td>-2.08</td>
<td>0.17</td>
<td>This study</td>
</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>MUN-3</td>
<td>-0.95</td>
<td>0.14</td>
<td>-1.90</td>
<td>0.36</td>
<td>10</td>
<td>-</td>
<td>-</td>
<td>-</td>
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</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>MUN-4</td>
<td>-1.05</td>
<td>0.15</td>
<td>-2.05</td>
<td>0.30</td>
<td>25</td>
<td>-</td>
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</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>Peixe</td>
<td>-0.23</td>
<td>0.10</td>
<td>-0.43</td>
<td>0.19</td>
<td>11</td>
<td>-</td>
<td>-</td>
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</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>Plešovice-MG</td>
<td>-0.21</td>
<td>0.07</td>
<td>-0.38</td>
<td>0.18</td>
<td>11</td>
<td>S-MC-ICP-MS</td>
<td>-0.39</td>
<td>0.06</td>
<td>This study</td>
</tr>
<tr>
<td>LA-MC-ICP-MS</td>
<td>QGNG</td>
<td>-0.21</td>
<td>0.05</td>
<td>-0.38</td>
<td>0.10</td>
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<td>-</td>
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</tr>
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<td>LA-MC-ICP-MS</td>
<td>R33</td>
<td>-0.22</td>
<td>0.04</td>
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<td>0.08</td>
<td>8</td>
<td>-</td>
<td>-</td>
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<td>-</td>
</tr>
</tbody>
</table>

* relative to NBS 28

Data from other techniques:

- This study
- Trail et al. (2018)